

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TAKAIWA ET AL.	
		Examiner Kelly L. Jerabek	Art Unit 2622	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	D	US-6,515,704	02-2003	Sato, Kazuya	348/333.11
*	E	US-2002/0024608	02-2002	Ejima et al.	348/333.05
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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